

# **Description**

The VSM100N03 uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications.

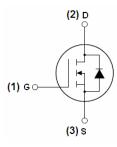
#### **General Features**

- $V_{DS} = 30V, I_D = 100A$  $R_{DS(ON)} < 5.5m\Omega @ V_{GS} = 10V$  (Typ:4m $\Omega$ )
- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E<sub>AS</sub>
- Excellent package for good heat dissipation
- Special process technology for high ESD capability

## **Application**

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply





Schematic Diagram

### **Package Marking and Ordering Information**

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VSM100N03-TC	VSM100N03	TO-220C	-	-	-

## Absolute Maximum Ratings (T<sub>A</sub>=25 ℃ unless otherwise noted)

<b>U</b> ( 1)				
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	30	V	
Gate-Source Voltage	V <sub>G</sub> s	±20	V	
Drain Current-Continuous	I <sub>D</sub>	100	Α	
Drain Current-Continuous(T <sub>C</sub> =100℃)	I <sub>D</sub> (100℃)	70	А	
Pulsed Drain Current	I <sub>DM</sub>	400	А	
Maximum Power Dissipation	P <sub>D</sub>	110	W	
Single pulse avalanche energy (Note 5)	E <sub>AS</sub>	350	mJ	
Operating Junction and Storage Temperature Range	$T_J,T_STG$	-55 To 175	℃	



## **Thermal Characteristic**

Thermal Resistance, Junction-to-Case (Note 2)	R <sub>0JC</sub>	1.36	°C/W	
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## **Electrical Characteristics (T<sub>A</sub>=25**°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics			•			
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250µA	30	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =30V,V <sub>GS</sub> =0V	-	-	1	μΑ
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±100	nA
On Characteristics (Note 3)			•			
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$	1	1.6	3	V
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =20A	-	4.0	5.5	mΩ
Forward Transconductance	<b>g</b> Fs	V <sub>DS</sub> =10V,I <sub>D</sub> =20A	50	-	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C <sub>lss</sub>	- V <sub>DS</sub> =25V,V <sub>GS</sub> =0V, -		3300		PF
Output Capacitance	C <sub>oss</sub>			356		PF
Reverse Transfer Capacitance	C <sub>rss</sub>	F=1.0MHz		308		PF
Switching Characteristics (Note 4)			•			
Turn-on Delay Time	t <sub>d(on)</sub>	$V_{DD}$ =15V, $I_{D}$ =30A $V_{GS}$ =4.5V, $R_{GEN}$ =1.8 $\Omega$	-	11	-	nS
Turn-on Rise Time	t <sub>r</sub>		-	160	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>		-	25	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	60	-	nS
Total Gate Charge	Qg	- V <sub>DS</sub> =15V,I <sub>D</sub> =30A,		70		nC
Gate-Source Charge	Q <sub>gs</sub>			8.8		nC
Gate-Drain Charge	$Q_{gd}$	V <sub>GS</sub> =10V		16.3		nC
Drain-Source Diode Characteristics			•			
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =30A	-	-	1.2	V
Diode Forward Current (Note 2)	Is	-	-	-	100	Α
Reverse Recovery Time	t <sub>rr</sub>	TJ = 25°C, IF = 30A	-	56	-	nS
Reverse Recovery Charge	Qrr	di/dt = 100A/µs <sup>(Note3)</sup>	-	110	-	nC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

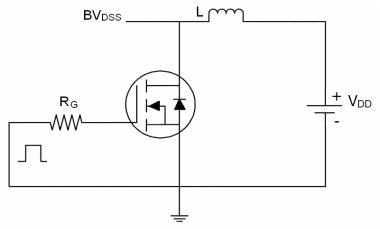
#### Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board,  $t \le 10$  sec.
- 3. Pulse Test: Pulse Width  $\leq$  300 $\mu$ s, Duty Cycle  $\leq$  2%.
- 4. Guaranteed by design, not subject to production
- **5.** EAS condition: Tj=25  $^{\circ}\text{C}$  ,VDD=15V,VG=10V,L=0.5mH,Rg=25 $\Omega$

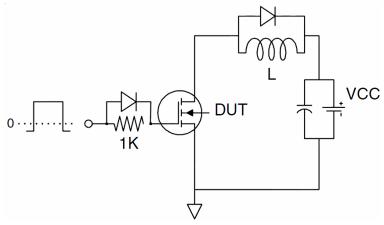


## **Test circuit**

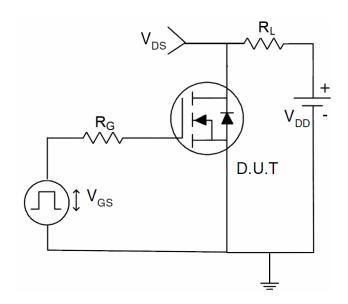
# 1) E<sub>AS</sub> test Circuits



# 2) Gate charge test Circuit:

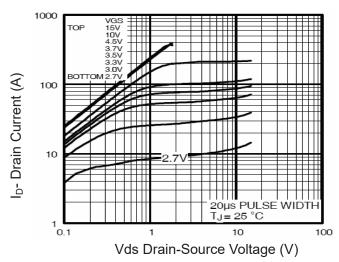


### 3) Switch Time Test Circuit:

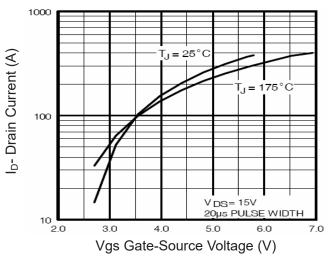




## Typical Electrical and Thermal Characteristics (Curves)



**Figure 1 Output Characteristics** 



**Figure 2 Transfer Characteristics** 

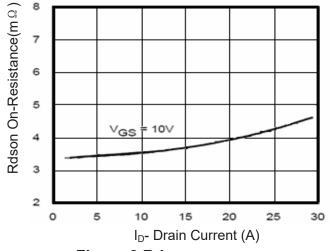


Figure 3 Rdson- Drain Current

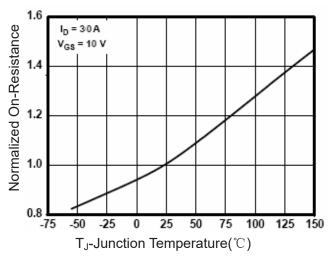


Figure 4 Rdson-JunctionTemperature

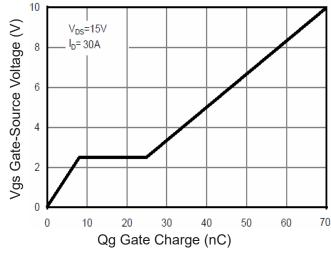


Figure 5 Gate Charge

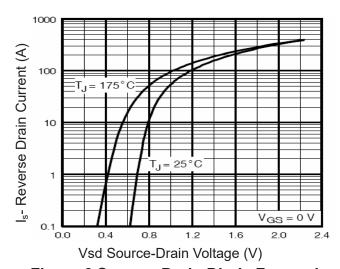


Figure 6 Source- Drain Diode Forward



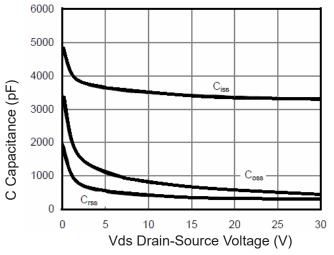


Figure 7 Capacitance vs Vds

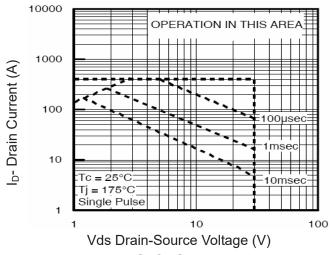


Figure 8 Safe Operation Area

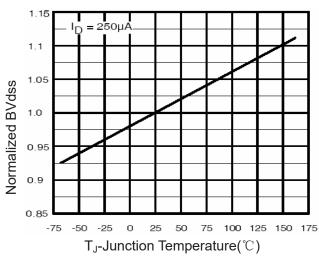


Figure 9 BV<sub>DSS</sub> vs Junction Temperature

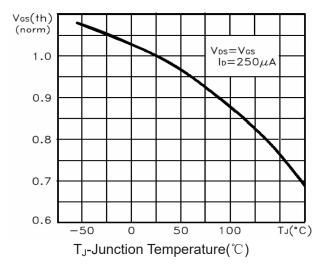


Figure 10 V<sub>GS(th)</sub> vs Junction Temperature

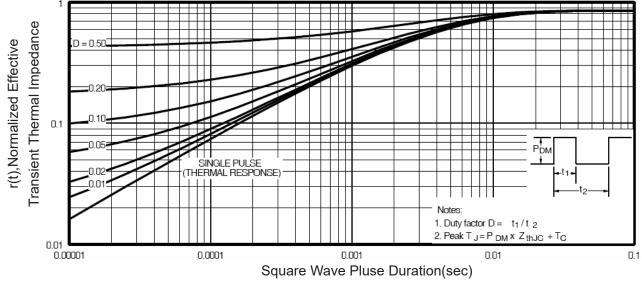


Figure 11 Normalized Maximum Transient Thermal Impedance